

Notice of References Cited

Application/Control No.

10/538,124

Applicant(s)/Patent Under
Reexamination
SCHNAIBEL ET AL.

Examiner

Thomas P. Noland

Art Unit

2856

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,532,013 A	07-1985	Dietz et al.	204/401 X
*	B	US-5,370,101 A	12-1994	Hamburg et al.	123/688
*	C	US-5,423,203 A	06-1995	Namiki et al.	73/1.06
*	D	US-5,494,557 A	02-1996	Hotzel et al.	204/425 X
*	E	US-5,488,858 A	02-1996	Achleitner, Erwin	73/1.06 X
*	F	US-6,073,083 A	06-2000	Schnaibel et al.	702/65
*	G	US-6,099,717 A	08-2000	Yamada et al.	204/401 X
*	H	US-6,120,663 A	09-2000	Kato et al.	204/401
*	I	US-6,294,075 B1	09-2001	Poggio et al.	204/406 X
*	J	US-6,439,038 B1	08-2002	Rosel et al.	73/117.3
*	K	US-6,482,310 B2	11-2002	Detwiler et al.	205/784.5
*	L	US-6,711,932 B2	03-2004	Iwazaki et al.	73/1.06
*	M	US-6,935,155 B2	08-2005	Yasui et al.	73/1.06

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 59168357 A	09-1984	Japan	NAKAZAWA et al.	73/1.03
	O	JP 59160747 A	09-1984	Japan	SUZUKI, FUJIYUKI	73/1.03
	P	JP 63304151 A	12-1988	Japan	YOSHIDA, HIDEJI	73/31.05
	Q	JP 07166940 A	06-1995	Japan	HAMBURG et al.	F02D 41/14
	R	JP 08105343 A	04-1996	Japan	MIYATA et al.	F02D 41/14
	S	JP 09137717 A	05-1997	Japan	SHOJI et al.	F01N 3/22
	T	JP 2000097893 A	04-2000	Japan	SAEKI et al.	G01N 27/12

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.